

Notice of References Cited	Application/Control No. 10/616,604	Applicant(s)/Patent Under Reexamination MASSE, WAYNE P.	
	Examiner Hiep T. Nguyen	Art Unit 2187	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	C	US-6,449,689	09-2002	Corcoran et al.	711/113
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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